

# TMUX1511 低容量、1:1 (SPST) 4チャンネル、 1.8Vロジックで電源オフ保護されたスイッチ

## 1 特長

- 広い電源電圧範囲: 1.5V~5.5V
- 小さいオン容量: 3.3pF
- 低いオン抵抗: 2Ω
- 高い帯域幅: 3GHz
- -40°C~+125°Cの動作温度範囲
- 1.8Vロジック互換
- 電源電圧を超える入力電圧に対応
- ロジック・ピンにプルダウン抵抗を内蔵
- 双方向の信号パス
- フェイルセーフ・ロジック
- 電源オフ保護 最大3.6V
  - SN74CBTLV3126とピン配置互換
  - SN74CBTLV3125とピン配置互換(ロジック・バリエーション)

## 2 アプリケーション

- サーバー
- 有線ネットワーク
- ワイヤレス・インフラ
- データ・センターのスイッチおよびルーター
- PC/ノートPC
- ビルディング・オートメーション
- ePOS
- モータ駆動
- 家電製品
- バッテリー駆動の機器
- JTAG絶縁
- SPI絶縁

## 3 概要

TMUX1511は、相補型金属酸化膜半導体(CMOS)スイッチです。TMUX1511は、4チャンネルの1:1 SPSTスイッチ構成を提供し、各チャンネルは独立に制御されます。動作電圧範囲が1.5V~5.5Vと広いと、サーバーや通信機器から産業用途まで、広範なアプリケーションに使用できます。このデバイスは、ソース(Sx)ピンとドレイン(Dx)ピンで双方向のアナログおよびデジタル信号をサポートし、電源電圧を超えて、最大で $V_{DD} \times 2$  (最大入出力電圧は5.5V)の信号を通すことができます。

TMUX1511の信号経路には最大3.6Vの電源オフ保護が備えられ、電源電圧が取り除かれたとき( $V_{DD} = 0V$ )も絶縁を提供します。この保護機能がないと、内部ESDダイオード経由でスイッチから電源レールに電流が流れ込み、システムに損傷を引き起こすおそれがあります。

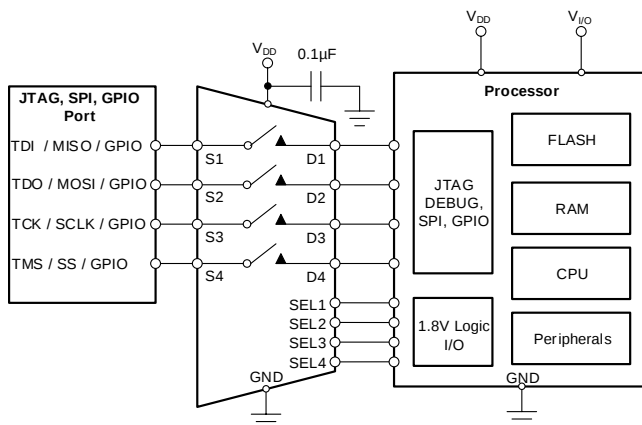
フェイルセーフ・ロジック回路により、電源ピンよりも前にロジック制御ピンに電圧が印加されるため、デバイスへの損傷の可能性が避けられます。すべてのロジック制御入力には1.8Vロジック互換のスレッシュホルドがあり、有効な電源電圧範囲で動作していれば、TTLとCMOSの両方のロジックと互換性が保証されます。

### 製品情報<sup>(1)</sup>

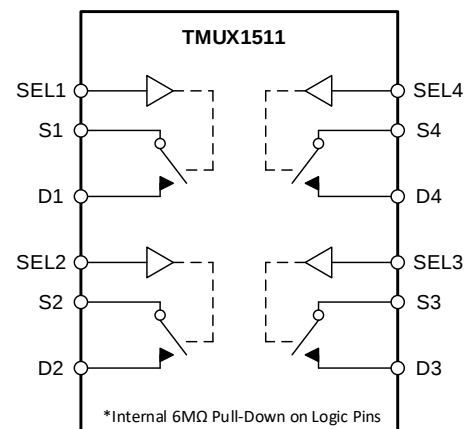
| 型番       | パッケージ      | 本体サイズ(公称)     |
|----------|------------|---------------|
| TMUX1511 | TSSOP (14) | 5.00mm×4.40mm |
|          | QFN (16)   | 2.60mm×1.80mm |

(1) 利用可能なすべてのパッケージについては、このデータシートの末尾にあるパッケージ・オプションについての付録を参照してください。

### アプリケーションの例



### ブロック図



## 目次

|          |                                                |           |           |                                             |           |
|----------|------------------------------------------------|-----------|-----------|---------------------------------------------|-----------|
| <b>1</b> | <b>特長</b> .....                                | <b>1</b>  | 7.11      | Off Isolation .....                         | <b>17</b> |
| <b>2</b> | <b>アプリケーション</b> .....                          | <b>1</b>  | 7.12      | Channel-to-Channel Crosstalk .....          | <b>17</b> |
| <b>3</b> | <b>概要</b> .....                                | <b>1</b>  | 7.13      | Bandwidth .....                             | <b>18</b> |
| <b>4</b> | <b>改訂履歴</b> .....                              | <b>2</b>  | <b>8</b>  | <b>Detailed Description</b> .....           | <b>19</b> |
| <b>5</b> | <b>Pin Configuration and Functions</b> .....   | <b>3</b>  | 8.1       | Overview .....                              | <b>19</b> |
| <b>6</b> | <b>Specifications</b> .....                    | <b>4</b>  | 8.2       | Functional Block Diagram .....              | <b>19</b> |
| 6.1      | Absolute Maximum Ratings .....                 | <b>4</b>  | 8.3       | Feature Description .....                   | <b>19</b> |
| 6.2      | ESD Ratings .....                              | <b>4</b>  | 8.4       | Device Functional Modes .....               | <b>20</b> |
| 6.3      | Recommended Operating Conditions .....         | <b>4</b>  | 8.5       | Truth Tables .....                          | <b>20</b> |
| 6.4      | Thermal Information .....                      | <b>4</b>  | <b>9</b>  | <b>Application and Implementation</b> ..... | <b>21</b> |
| 6.5      | Electrical Characteristics .....               | <b>5</b>  | 9.1       | Application Information .....               | <b>21</b> |
| 6.6      | Dynamic Characteristics .....                  | <b>6</b>  | 9.2       | Typical Application .....                   | <b>21</b> |
| 6.7      | Timing Requirements .....                      | <b>6</b>  | <b>10</b> | <b>Power Supply Recommendations</b> .....   | <b>23</b> |
| 6.8      | Typical Characteristics .....                  | <b>7</b>  | <b>11</b> | <b>Layout</b> .....                         | <b>24</b> |
| <b>7</b> | <b>Parameter Measurement Information</b> ..... | <b>12</b> | 11.1      | Layout Guidelines .....                     | <b>24</b> |
| 7.1      | On-Resistance .....                            | <b>12</b> | 11.2      | Layout Example .....                        | <b>25</b> |
| 7.2      | Off-Leakage Current .....                      | <b>12</b> | <b>12</b> | <b>デバイスおよびドキュメントのサポート</b> .....             | <b>26</b> |
| 7.3      | On-Leakage Current .....                       | <b>13</b> | 12.1      | ドキュメントのサポート .....                           | <b>26</b> |
| 7.4      | IPOFF Leakage Current .....                    | <b>13</b> | 12.2      | ドキュメントの更新通知を受け取る方法 .....                    | <b>26</b> |
| 7.5      | Transition Time .....                          | <b>14</b> | 12.3      | コミュニティ・リソース .....                           | <b>26</b> |
| 7.6      | $T_{ON}$ (VDD) and $T_{OFF}$ (VDD) Time .....  | <b>14</b> | 12.4      | 商標 .....                                    | <b>26</b> |
| 7.7      | Propagation Delay .....                        | <b>15</b> | 12.5      | 静電気放電に関する注意事項 .....                         | <b>26</b> |
| 7.8      | Skew .....                                     | <b>15</b> | 12.6      | Glossary .....                              | <b>26</b> |
| 7.9      | Charge Injection .....                         | <b>16</b> | <b>13</b> | <b>メカニカル、パッケージ、および注文情報</b> .....            | <b>26</b> |
| 7.10     | Capacitance .....                              | <b>16</b> |           |                                             |           |

## 4 改訂履歴

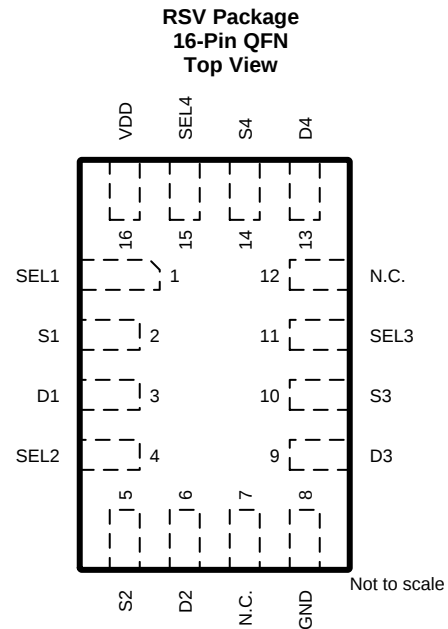
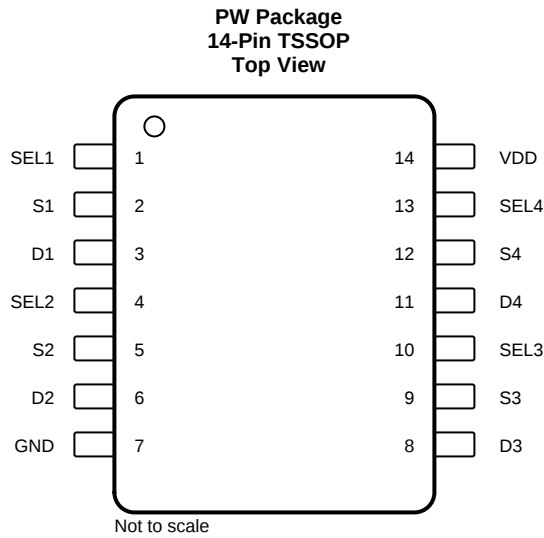
資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

### 2018年9月発行のものから更新

Page

|                                         |          |
|-----------------------------------------|----------|
| • データシートのステータスを「事前情報」から「量産データ」に変更 ..... | <b>1</b> |
|-----------------------------------------|----------|

## 5 Pin Configuration and Functions



### Pin Functions

| PIN  |       |      | TYPE <sup>(1)</sup> | DESCRIPTION                                                                                                                                                                                       |
|------|-------|------|---------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME | TSSOP | UQFN |                     |                                                                                                                                                                                                   |
| SEL1 | 1     | 1    | I                   | Select pin 1: controls state of switch #1 (logic low = OFF, logic high = ON). Internal 6 MΩ pull-down to GND.                                                                                     |
| S1   | 2     | 2    | I/O                 | Source pin 1. Can be an input or output.                                                                                                                                                          |
| D1   | 3     | 3    | I/O                 | Drain pin 1. Can be an input or output.                                                                                                                                                           |
| SEL2 | 4     | 4    | I                   | Select pin 2: controls state of switch #2 (logic low = OFF, logic high = ON). Internal 6 MΩ pull-down to GND.                                                                                     |
| S2   | 5     | 5    | I/O                 | Source pin 2. Can be an input or output.                                                                                                                                                          |
| D2   | 6     | 6    | I/O                 | Drain pin 2. Can be an input or output.                                                                                                                                                           |
| N.C. | -     | 7    | Not Connected       | Not Connected - Can be shorted to GND or left floating                                                                                                                                            |
| GND  | 7     | 8    | P                   | Ground (0 V) reference                                                                                                                                                                            |
| D3   | 8     | 9    | I/O                 | Drain pin 3. Can be an input or output.                                                                                                                                                           |
| S3   | 9     | 10   | I/O                 | Source pin 3. Can be an input or output.                                                                                                                                                          |
| SEL3 | 10    | 11   | I                   | Select pin 3: controls state of switch #3 (logic low = OFF, logic high = ON). Internal 6 MΩ pull-down to GND.                                                                                     |
| N.C. | -     | 12   | Not Connected       | Not Connected - Can be shorted to GND or left floating                                                                                                                                            |
| D4   | 11    | 13   | I/O                 | Drain pin 4. Can be an input or output.                                                                                                                                                           |
| S4   | 12    | 14   | I/O                 | Source pin 4. Can be an input or output.                                                                                                                                                          |
| SEL4 | 13    | 15   | I                   | Select pin 4: controls state of switch #4 (logic low = OFF, logic high = ON). Internal 6 MΩ pull-down to GND.                                                                                     |
| VDD  | 14    | 16   | P                   | Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 μF to 10 μF between V <sub>DD</sub> and GND. |

(1) I = input, O = output, I/O = input and output, P = power

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1) (2) (3)</sup>

|                                         |                                                               | MIN  | MAX | UNIT |
|-----------------------------------------|---------------------------------------------------------------|------|-----|------|
| V <sub>DD</sub>                         | Supply voltage                                                | –0.5 | 6   | V    |
| V <sub>SEL</sub>                        | Logic control input pin voltage (SEL1, SEL2, SEL3, SEL4)      | –0.5 | 6   | V    |
| I <sub>SEL</sub>                        | Logic control input pin current (SEL1, SEL2, SEL3, SEL4)      | –30  | 30  | mA   |
| V <sub>S</sub> or V <sub>D</sub>        | Source or drain pin voltage                                   | –0.5 | 6   | V    |
| I <sub>S</sub> or I <sub>D</sub> (CONT) | Source and drain pin continuous current: (S1 to S4, D1 to D4) | –25  | 25  | mA   |
| T <sub>stg</sub>                        | Storage temperature                                           | –65  | 150 | °C   |
| T <sub>J</sub>                          | Junction temperature                                          |      | 150 | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.
- (3) All voltages are with respect to ground, unless otherwise specified.

### 6.2 ESD Ratings

|                    |                         |                                                                                | VALUE | UNIT |
|--------------------|-------------------------|--------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±2000 | V    |
|                    |                         | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±750  |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

|                                          |                                                                                                | MIN | MAX                 | UNIT |
|------------------------------------------|------------------------------------------------------------------------------------------------|-----|---------------------|------|
| V <sub>DD</sub>                          | Supply voltage                                                                                 | 1.5 | 5.5                 | V    |
| V <sub>S</sub> or V <sub>D</sub>         | Signal path input/output voltage (source or drain pin), V <sub>DD</sub> ≥ 1.5 V <sup>(1)</sup> | 0   | V <sub>DD</sub> × 2 | V    |
| V <sub>S_off</sub> or V <sub>D_off</sub> | Signal path input/output voltage (source or drain pin), V <sub>DD</sub> < 1.5 V <sup>(2)</sup> | 0   | 3.6                 | V    |
| V <sub>SEL</sub>                         | Logic control input voltage (SELx)                                                             | 0   | 5.5                 | V    |
| T <sub>A</sub>                           | Ambient temperature                                                                            | –40 | 125                 | °C   |

- (1) Device input/output can operate up to V<sub>DD</sub> × 2, with a maximum input/output voltage of 5.5 V.
- (2) V<sub>S\_off</sub> and V<sub>D\_off</sub> refers to the voltage at the source or drain pins when supply is less than 1.5 V

### 6.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | DEVICE     | DEVICE     | UNIT |
|-------------------------------|----------------------------------------------|------------|------------|------|
|                               |                                              | PW (TSSOP) | RSV (UQFN) |      |
|                               |                                              | 14 PINS    | 16 PINS    |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 129.4      | 141.5      | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 58.8       | 77.9       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 72.4       | 67.6       | °C/W |
| Ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 11.6       | 5.1        | °C/W |
| Ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 71.9       | 65.5       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | N/A        | N/A        | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics

 $V_{DD} = 1.5 \text{ V to } 5.5 \text{ V}$ ,  $GND = 0 \text{ V}$ ,  $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ ,

Typical values are at  $V_{DD} = 3.3 \text{ V}$ ,  $T_A = 25^\circ\text{C}$ , (unless otherwise noted)

| PARAMETER                    |                                                 | TEST CONDITIONS                                                                                                                                                                                     | MIN  | TYP  | MAX     | UNIT          |
|------------------------------|-------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|---------|---------------|
| <b>POWER SUPPLY</b>          |                                                 |                                                                                                                                                                                                     |      |      |         |               |
| $V_{DD}$                     | Power supply voltage                            |                                                                                                                                                                                                     | 1.5  |      | 5.5     | V             |
| $I_{DD}$                     | Supply current                                  | $V_{SEL} = 0 \text{ V, } 1.4 \text{ V or } V_{DD}$<br>$V_S = 0 \text{ V to } 5.5 \text{ V}$                                                                                                         |      | 37   | 70      | $\mu\text{A}$ |
| <b>DC CHARACTERISTICS</b>    |                                                 |                                                                                                                                                                                                     |      |      |         |               |
| $R_{ON}$                     | On-resistance                                   | $V_S = 0 \text{ V to } V_{DD} \times 2$<br>$V_{S(max)} = 5.5 \text{ V}$<br>$I_{SD} = 8 \text{ mA}$<br>Refer to <a href="#">ON-State Resistance Figure</a>                                           |      | 2    | 4.5     | $\Omega$      |
| $\Delta R_{ON}$              | On-resistance match between channels            | $V_S = V_{DD}$<br>$I_{SD} = 8 \text{ mA}$<br>Refer to <a href="#">ON-State Resistance Figure</a>                                                                                                    |      | 0.07 | 0.28    | $\Omega$      |
| $R_{ON}$<br>(FLAT)           | On-resistance flatness                          | $V_S = 0 \text{ V to } V_{DD}$<br>$I_{SD} = 8 \text{ mA}$<br>Refer to <a href="#">ON-State Resistance Figure</a>                                                                                    |      | 1    | 1.8     | $\Omega$      |
| $I_{POFF}$                   | Powered-off I/O pin leakage current             | $V_{DD} = 0 \text{ V}$<br>$V_S = 0 \text{ V to } 3 \text{ V}$<br>$V_D = 0 \text{ V}$<br>$T_A = 25^\circ\text{C}$<br>Refer to <a href="#">I<sub>po</sub>ff Leakage Figure</a>                        | -10  | 0.01 | 10      | nA            |
| $I_{POFF}$                   | Powered-off I/O pin leakage current             | $V_{DD} = 0 \text{ V}$<br>$V_S = 0 \text{ V to } 3.6 \text{ V}$<br>$V_D = 0 \text{ V}$<br>Refer to <a href="#">I<sub>po</sub>ff Leakage Figure</a>                                                  | -2   | 0.01 | 2       | $\mu\text{A}$ |
| $I_{S(OFF)}$<br>$I_{D(OFF)}$ | OFF leakage current                             | Switch Off<br>$V_D = 0.8 \times V_{DD} / 0.2 \times V_{DD}$<br>$V_S = 0.2 \times V_{DD} / 0.8 \times V_{DD}$<br>Refer to <a href="#">Off Leakage Figure</a>                                         | -100 | 0.03 | 100     | nA            |
| $I_{D(ON)}$<br>$I_{S(ON)}$   | ON leakage current                              | Switch On<br>$V_D = 0.8 \times V_{DD} / 0.2 \times V_{DD}$ , S pins floating<br>or<br>$V_S = 0.8 \times V_{DD} / 0.2 \times V_{DD}$ , D pins floating<br>Refer to <a href="#">On Leakage Figure</a> | -50  | 0.01 | 50      | nA            |
| <b>LOGIC INPUTS</b>          |                                                 |                                                                                                                                                                                                     |      |      |         |               |
| $V_{IH}$                     | Input logic high                                |                                                                                                                                                                                                     | 1.2  |      | 5.5     | V             |
| $V_{IL}$                     | Input logic low                                 |                                                                                                                                                                                                     | 0    |      | 0.45    | V             |
| $I_{IH}$                     | Input high leakage current                      | $V_{SEL} = 1.8 \text{ V, } V_{DD}$                                                                                                                                                                  |      | 1    | $\pm 2$ | $\mu\text{A}$ |
| $I_{IL}$                     | Input low leakage current                       | $V_{SEL} = 0 \text{ V}$                                                                                                                                                                             |      | 0.2  | $\pm 2$ | $\mu\text{A}$ |
| $R_{PD}$                     | Internal pull-down resistor on logic input pins |                                                                                                                                                                                                     |      | 6    |         | M $\Omega$    |
| $C_I$                        | Logic input capacitance                         | $V_{SEL} = 0 \text{ V, } 1.8 \text{ V or } V_{DD}$<br>$f = 1 \text{ MHz}$                                                                                                                           |      | 3    |         | pF            |

## 6.6 Dynamic Characteristics

 $V_{DD} = 1.5\text{ V to }5.5\text{ V}$ ,  $GND = 0\text{ V}$ ,  $T_A = -40^\circ\text{C to }+125^\circ\text{C}$ ,

 Typical values are at  $V_{DD} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$ , (unless otherwise noted)

| PARAMETER  |                                  | TEST CONDITIONS                                                                                                     |            | MIN | TYP   | MAX | UNIT |
|------------|----------------------------------|---------------------------------------------------------------------------------------------------------------------|------------|-----|-------|-----|------|
| $C_{OFF}$  | Source and drain off capacitance | $V_S = V_{DD} / 2$<br>$V_{SEL} = 0\text{ V}$<br>$f = 1\text{ MHz}$<br>Refer to <a href="#">Capacitance Figure</a>   | Switch OFF |     | 2.5   | 4   | pF   |
| $C_{ON}$   | Source and drain on capacitance  | $V_S = V_{DD} / 2$<br>$V_{SEL} = V_{DD}$<br>$f = 1\text{ MHz}$<br>Refer to <a href="#">Capacitance Figure</a>       | Switch ON  |     | 3.3   | 6   | pF   |
| $Q_C$      | Charge Injection                 | $V_S = V_{DD} / 2$<br>$R_S = 0\ \Omega$ , $C_L = 100\text{ pF}$<br>Refer to <a href="#">Charge Injection Figure</a> | Switch ON  |     | 2     |     | pC   |
| $O_{ISO}$  | Off isolation                    | $R_L = 50\ \Omega$<br>$f = 100\text{ kHz}$<br>Refer to <a href="#">Off Isolation Figure</a>                         | Switch OFF |     | -90   |     | dB   |
|            |                                  | $R_L = 50\ \Omega$<br>$f = 1\text{ MHz}$<br>Refer to <a href="#">Off Isolation Figure</a>                           | Switch OFF |     | -75   |     | dB   |
| $X_{TALK}$ | Channel to Channel crosstalk     | $R_L = 50\ \Omega$<br>$f = 100\text{ kHz}$<br>Refer to <a href="#">Crosstalk Figure</a>                             | Switch ON  |     | -90   |     | dB   |
| BW         | Bandwidth                        | $R_L = 50\ \Omega$<br>Refer to <a href="#">Bandwidth Figure</a>                                                     | Switch ON  |     | 3     |     | GHz  |
| $I_{LOSS}$ | Insertion loss                   | $R_L = 50\ \Omega$<br>$f = 1\text{ MHz}$<br>Refer to <a href="#">Bandwidth Figure</a>                               | Switch ON  |     | -0.12 |     | dB   |

## 6.7 Timing Requirements

 $V_{DD} = 1.5\text{ V to }5.5\text{ V}$ ,  $GND = 0\text{ V}$ ,  $T_A = -40^\circ\text{C to }+125^\circ\text{C}$ ,

 Typical values are at  $V_{DD} = 3.3\text{ V}$ ,  $T_A = 25^\circ\text{C}$ , (unless otherwise noted)

| PARAMETER      |                                            | TEST CONDITIONS                                                                                                                                                         |  | MIN | TYP | MAX | UNIT          |
|----------------|--------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--|-----|-----|-----|---------------|
| $t_{ON(VDD)}$  | Device turn on time ( $V_{DD}$ to output)  | $V_S = 3.6\text{ V}$<br>$V_{DD}$ rise time = $1\ \mu\text{s}$<br>$R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$<br>Refer to <a href="#">Ton(vdd) &amp; Toff(vdd) Figure</a> |  |     | 20  | 60  | $\mu\text{s}$ |
| $t_{OFF(VDD)}$ | Device turn off time ( $V_{DD}$ to output) | $V_S = 3.6\text{ V}$<br>$V_{DD}$ fall time = $1\ \mu\text{s}$<br>$R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$<br>Refer to <a href="#">Ton(vdd) &amp; Toff(vdd) Figure</a> |  |     | 1.2 | 4   | $\mu\text{s}$ |
| $t_{TRAN}$     | Transition time from control input         | $V_{DD} = 2.5\text{ V to }5.5\text{ V}$<br>$V_S = V_{DD}$<br>$R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$<br>Refer to <a href="#">Transition Time Figure</a>              |  |     | 25  | 55  | ns            |
| $t_{TRAN}$     | Transition time from control input         | $V_{DD} < 2.5\text{ V}$<br>$V_S = V_{DD}$<br>$R_L = 200\ \Omega$ , $C_L = 15\text{ pF}$<br>Refer to <a href="#">Transition Time Figure</a>                              |  |     | 50  | 80  | ns            |
| $t_{SK(P)}$    | Inter - channel skew                       | Refer to <a href="#">Tsk Figure</a>                                                                                                                                     |  |     | 10  |     | ps            |
| $t_{PD}$       | Propagation delay                          | Refer to <a href="#">Tpd Figure</a>                                                                                                                                     |  |     | 67  |     | ps            |

## 6.8 Typical Characteristics

at  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5\text{ V}$  (unless otherwise noted)

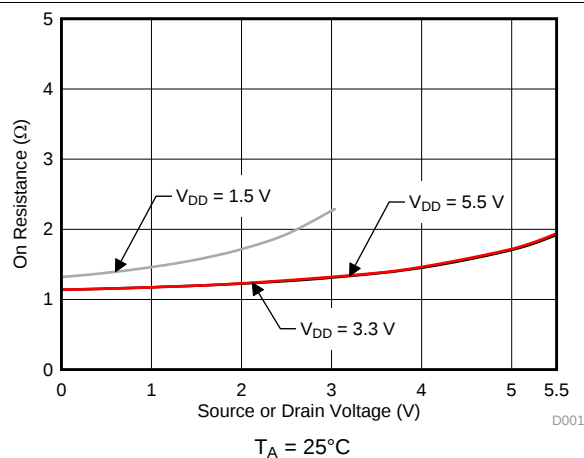


图 1. On-Resistance vs Source or Drain Voltage

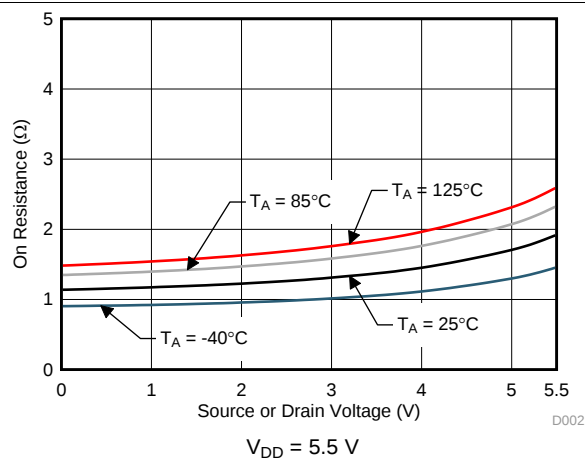


图 2. On-Resistance vs Source or Drain Voltage

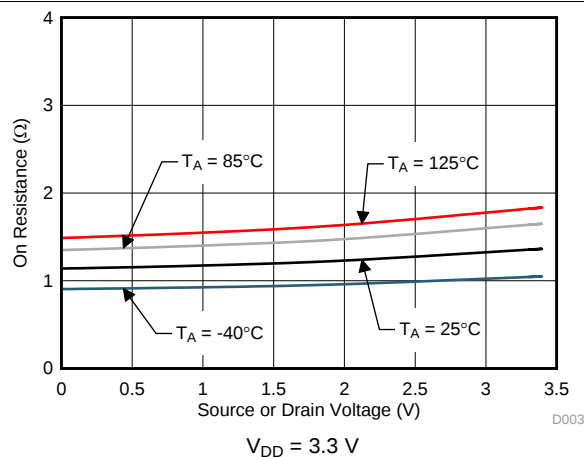


图 3. On-Resistance vs Source or Drain Voltage

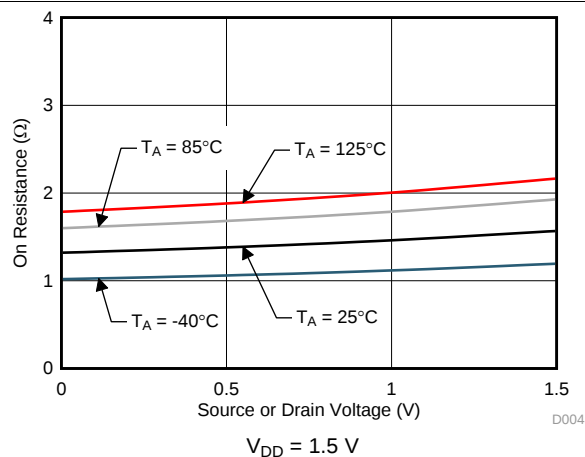


图 4. On-Resistance vs Source or Drain Voltage

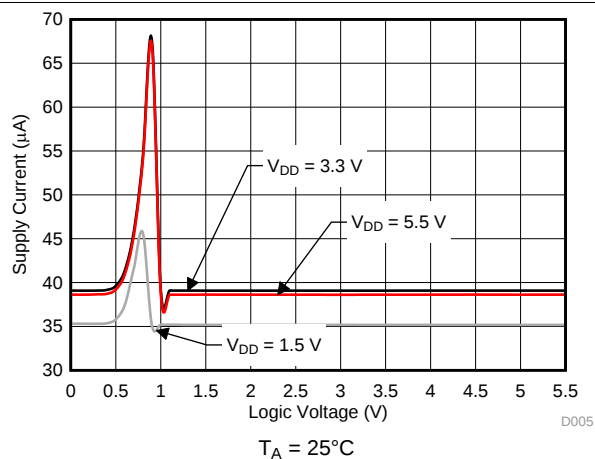


图 5. Supply Current vs Logic Voltage

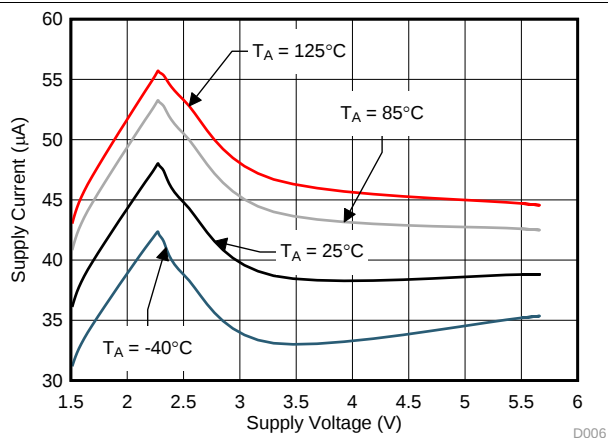


图 6. Supply Current vs Supply Voltage

## Typical Characteristics (continued)

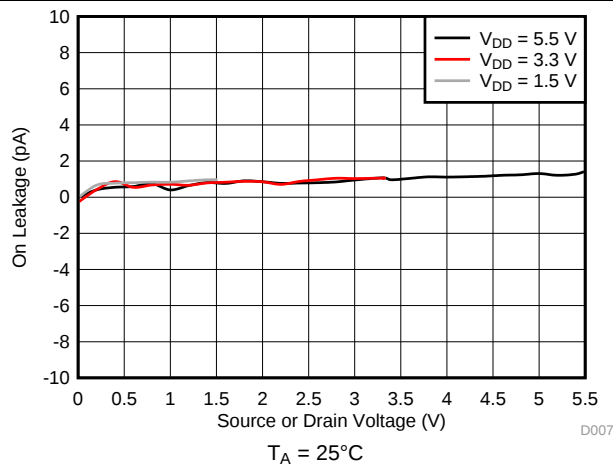


Figure 7. On-Leakage vs Source or Drain Voltage

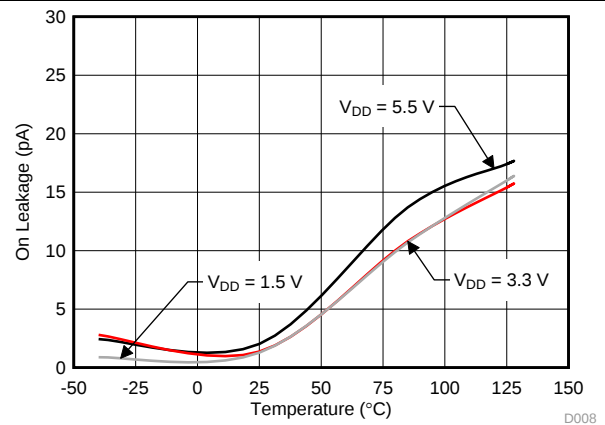


Figure 8. On-Leakage vs Temperature

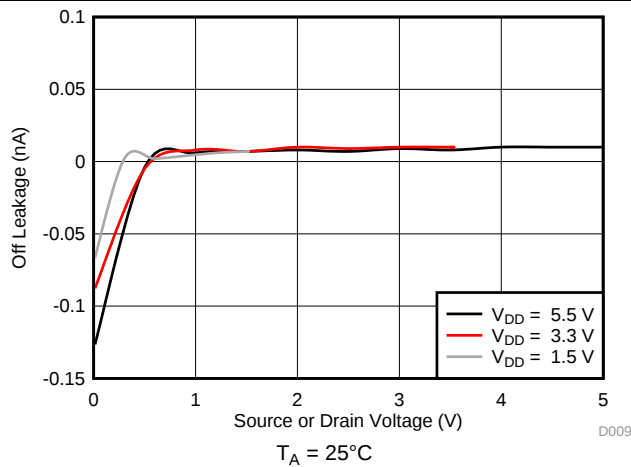


Figure 9. Off-Leakage vs Source or Drain Voltage

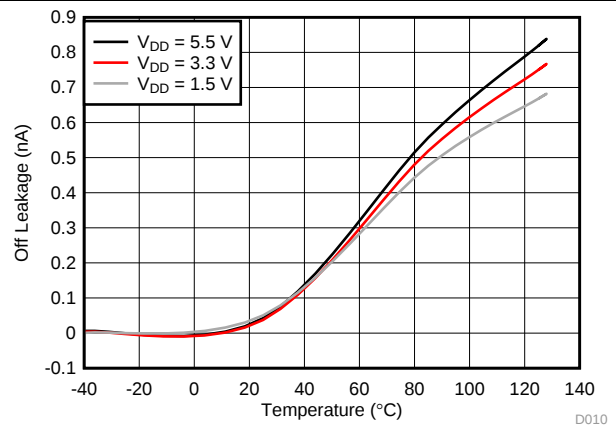


Figure 10. Off-Leakage vs Temperature

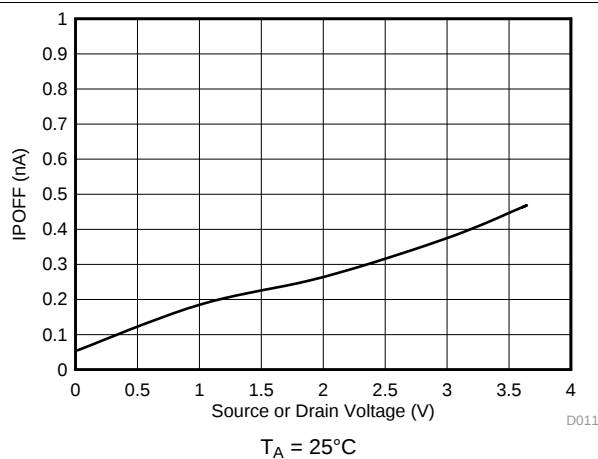


Figure 11. IPOFF Leakage vs Source or Drain Voltage

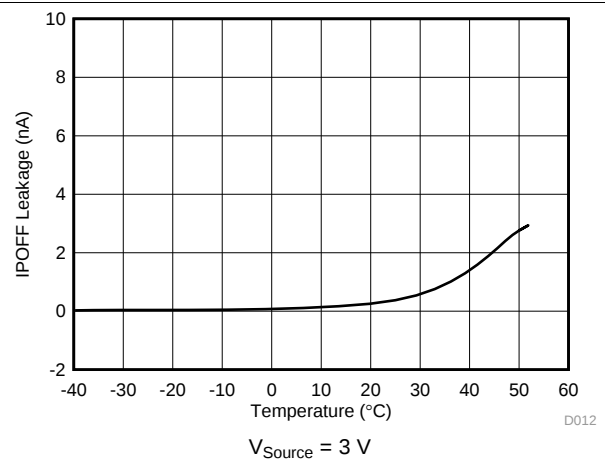
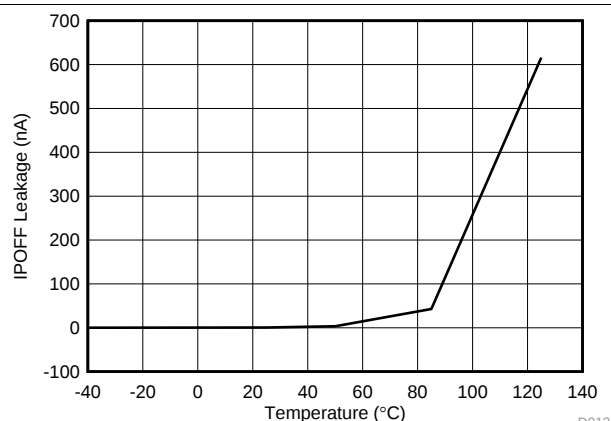


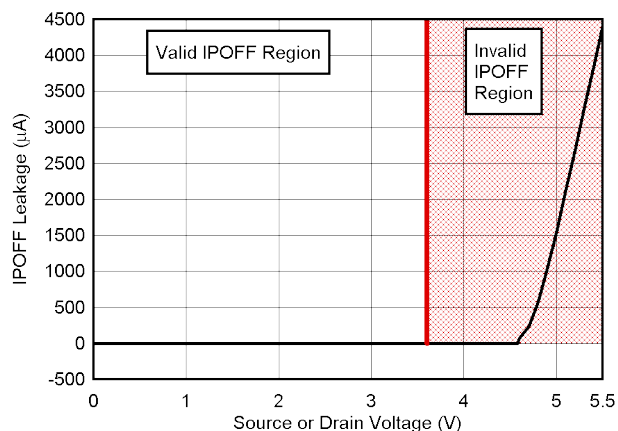
Figure 12. IPOFF Leakage vs Temperature

## Typical Characteristics (continued)



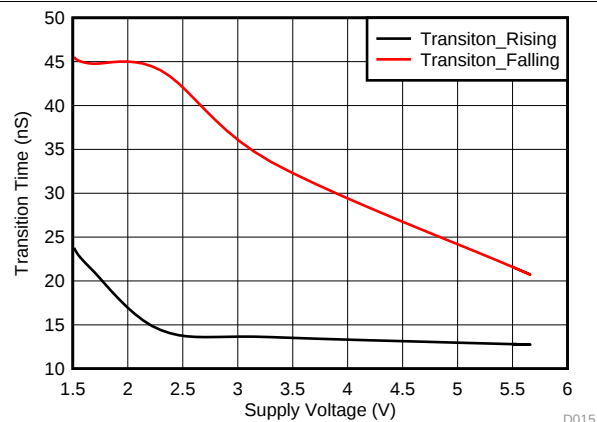
$V_{Source} = 3.6\text{ V}$   
 $V_{Drain} = 0\text{ V}$

FIG 13. IPOFF Leakage vs Temperature



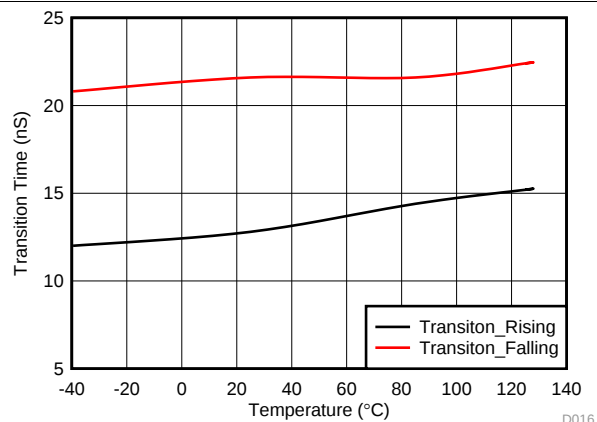
$T_A = 25^\circ\text{C}$   
 $R_L = 200\ \Omega$

FIG 14. IPOFF Leakage vs Source or Drain Voltage



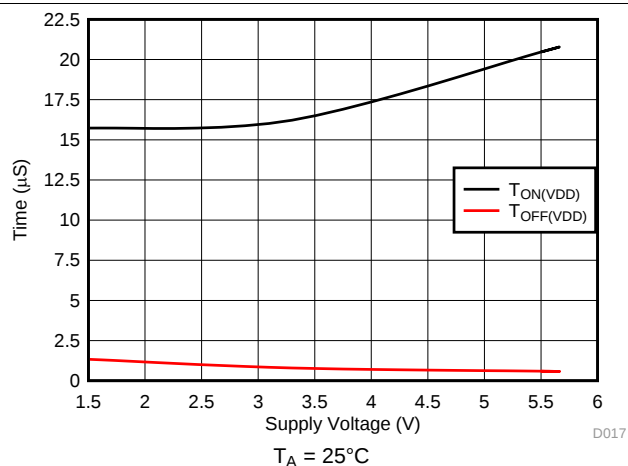
$T_A = 25^\circ\text{C}$

FIG 15.  $T_{TRANSITION}$  vs Supply Voltage



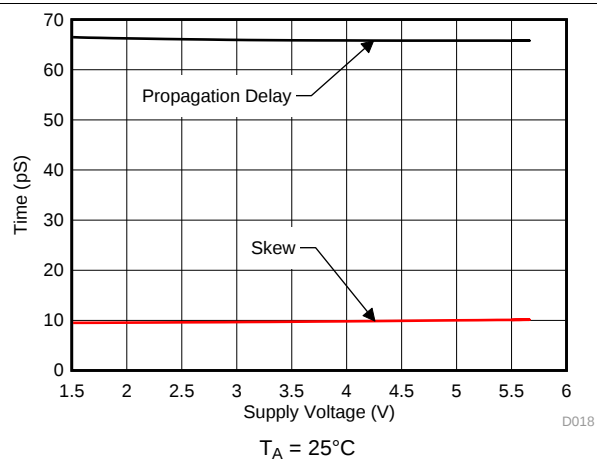
$V_{DD} = 5.5\text{ V}$

FIG 16.  $T_{TRANSITION}$  vs Temperature



$T_A = 25^\circ\text{C}$

FIG 17.  $T_{ON}(VDD)$  and  $T_{OFF}(VDD)$  vs Supply Voltage



$T_A = 25^\circ\text{C}$

FIG 18. Skew and Propagation Delay vs Supply Voltage

## Typical Characteristics (continued)

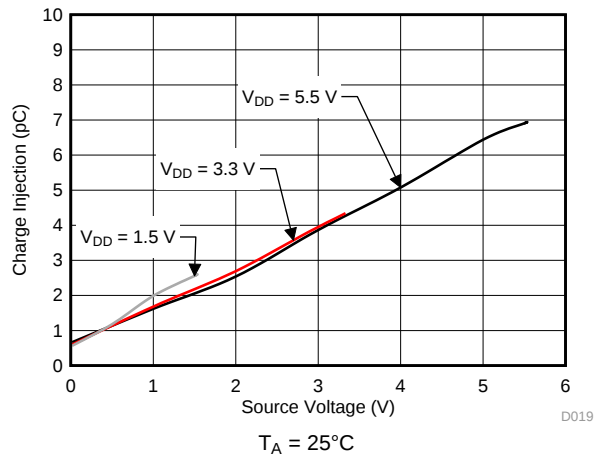


FIG 19. Charge Injection vs Source or Drain Voltage

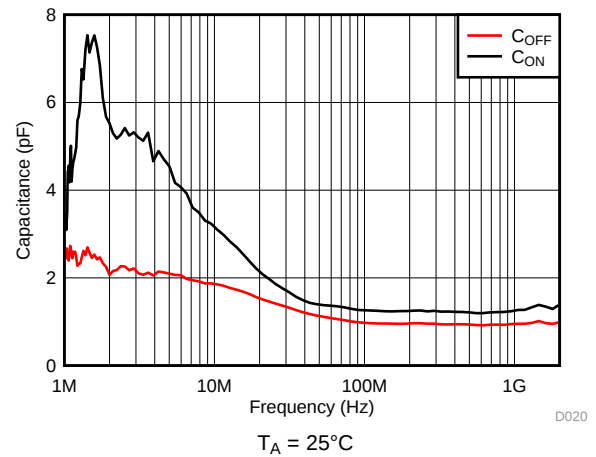


FIG 20. Capacitance vs Frequency

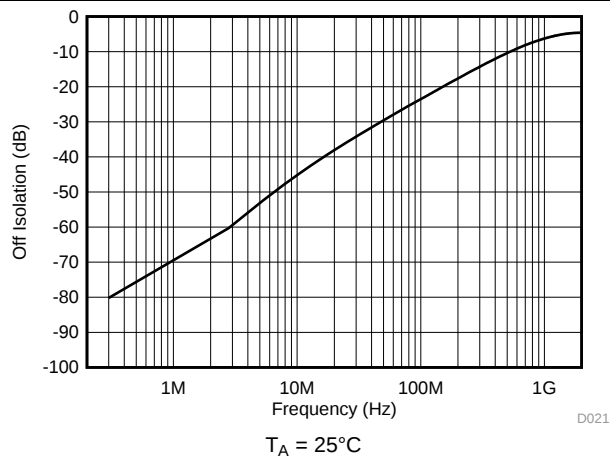


FIG 21. Off Isolation vs Frequency

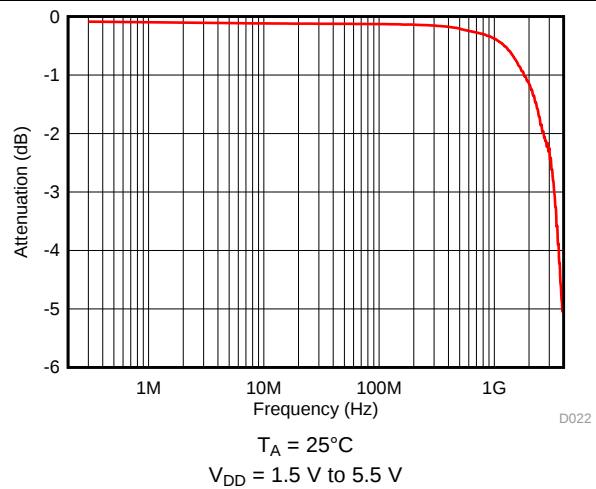
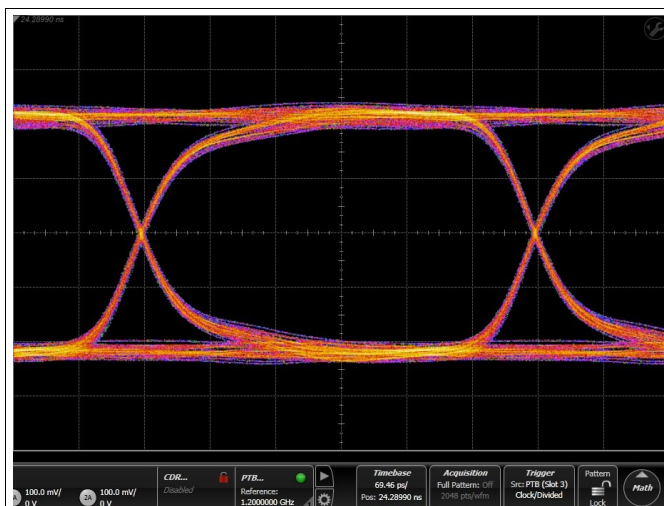


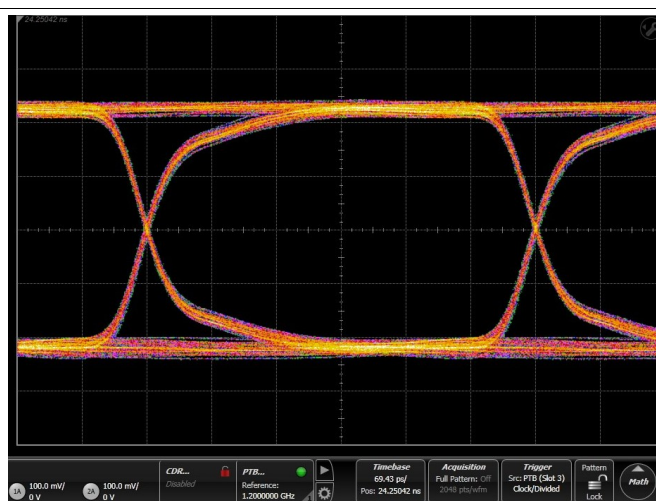
FIG 22. On-Response vs Frequency

## 6.8.1 Eye Diagrams



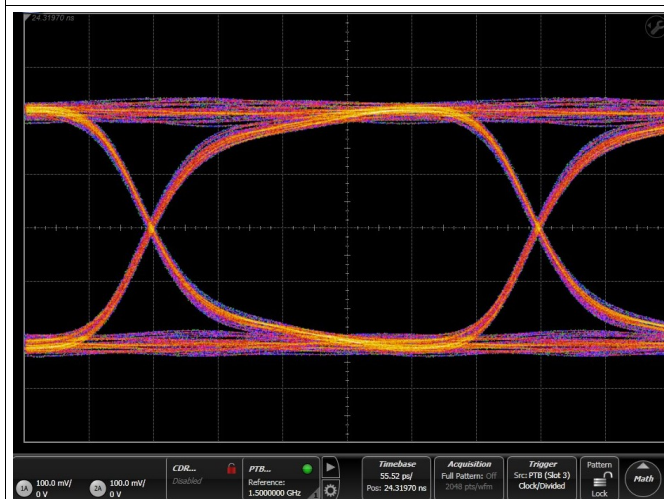
$T_A = 25^\circ\text{C}$   
Bias = 1.5 V  
50  $\Omega$  Termination

✎ 23. Eye Pattern: 2.4 Gbps



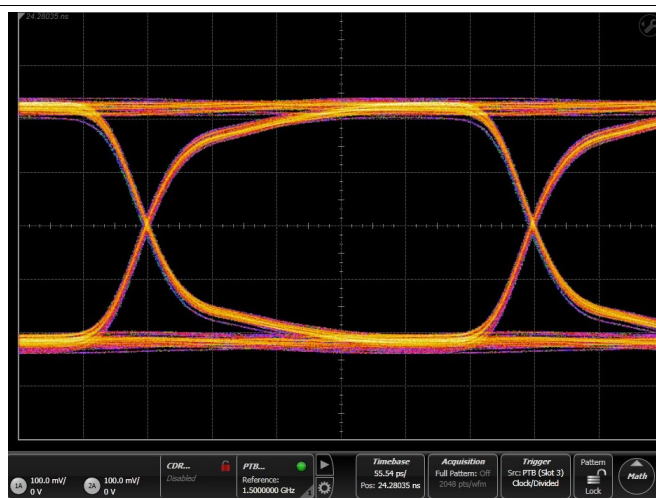
$T_A = 25^\circ\text{C}$   
Bias = 1.5 V  
50  $\Omega$  Termination

✎ 24. Eye Pattern: 2.4 Gbps Through Path



$T_A = 25^\circ\text{C}$   
Bias = 1.5 V  
50  $\Omega$  Termination

✎ 25. Eye Pattern: 3 Gbps



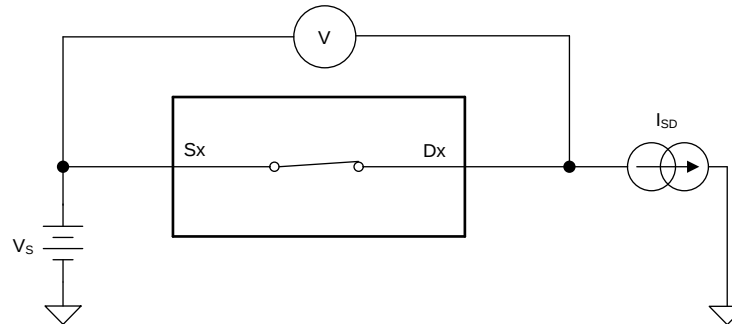
$T_A = 25^\circ\text{C}$   
Bias = 1.5 V  
50  $\Omega$  Termination

✎ 26. Eye Pattern: 3 Gbps Through Path

## 7 Parameter Measurement Information

### 7.1 On-Resistance

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (Dx) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol  $R_{ON}$  is used to denote on-resistance. The measurement setup used to measure  $R_{ON}$  is shown in [Figure 27](#). Voltage (V) and current ( $I_{DS}$ ) are measured using this setup, and  $R_{ON}$  is computed as shown below with  $R_{ON} = V / I_{SD}$ :



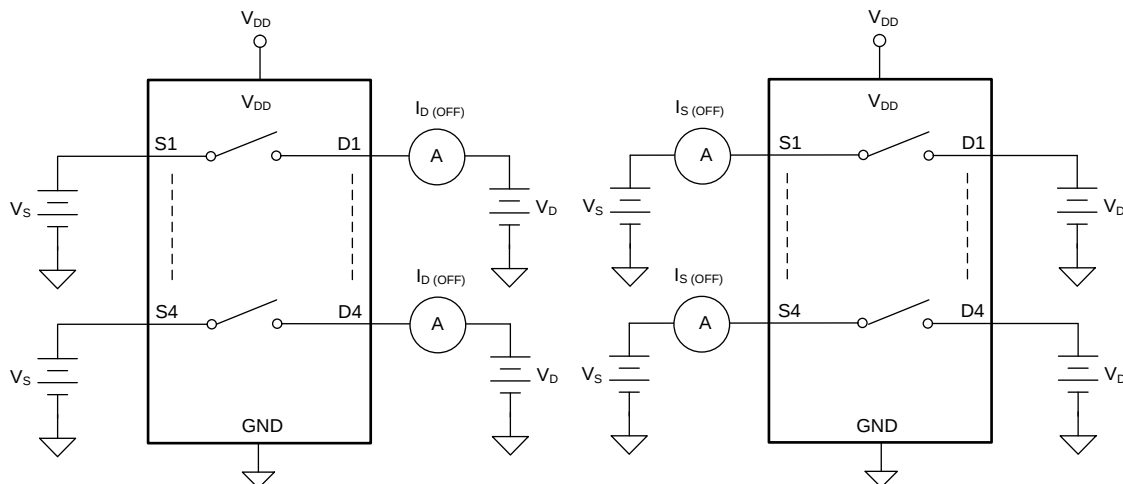
**Figure 27. On-Resistance Measurement Setup**

### 7.2 Off-Leakage Current

Source off-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol  $I_{S(OFF)}$ .

Drain off-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol  $I_{D(OFF)}$ .

The setup used to measure both off-leakage currents is shown in [Figure 28](#).



**Figure 28. Off-Leakage Measurement Setup**

### 7.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol  $I_{S(ON)}$ .

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol  $I_{D(ON)}$ .

Either the source pin or drain pin is left floating during the measurement. Figure 29 shows the circuit used for measuring the on-leakage current, denoted by  $I_{S(ON)}$  or  $I_{D(ON)}$ .

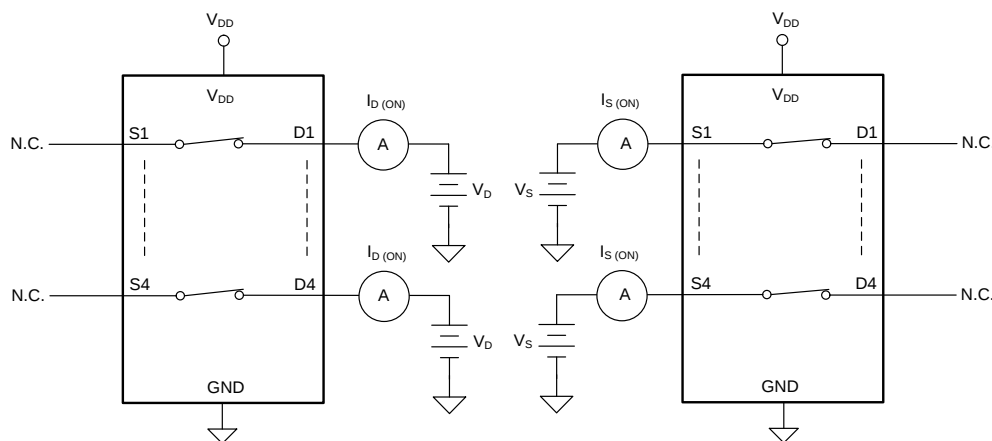


Figure 29. On-Leakage Measurement Setup

### 7.4 IPOFF Leakage Current

IPOFF leakage current is defined as the leakage current flowing into or out of the source pin when the device is powered off. This current is denoted by the symbol  $I_{POFF}$ .

The setup used to measure both IPOFF leakage current is shown in Figure 30.

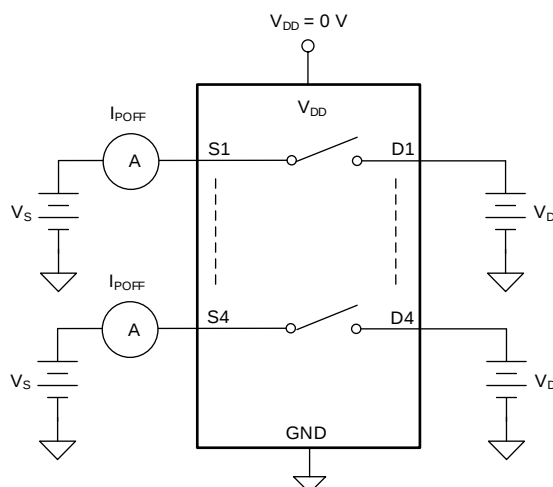
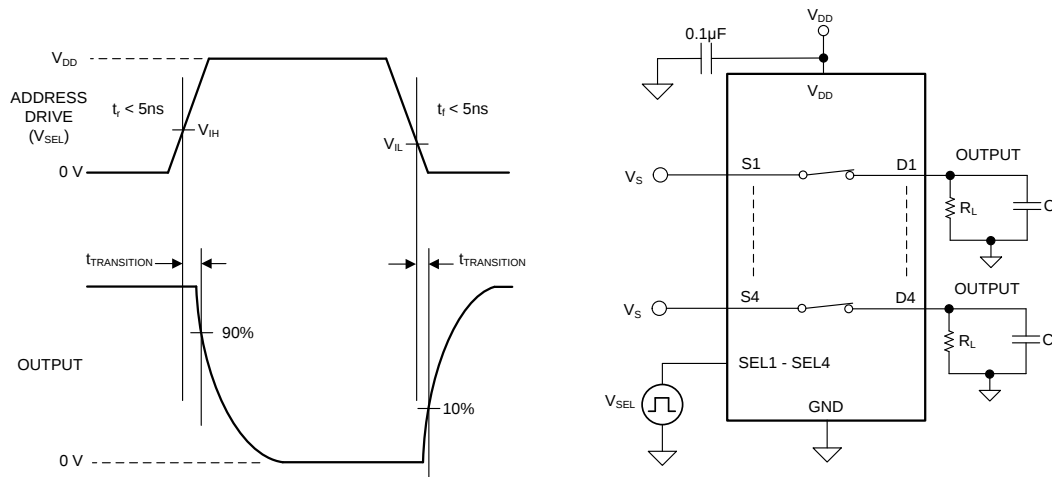


Figure 30. IPOFF Leakage Measurement Setup

## 7.5 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 10% after the control select signal has risen or fallen past the logic threshold. The 10% transition measurement is utilized to provide the timing of the device. The time constant from the load resistance and load capacitance can be added to the transition time to calculate system level timing. [Figure 31](#) shows the setup used to measure transition time, denoted by the symbol  $t_{\text{TRANSITION}}$ .

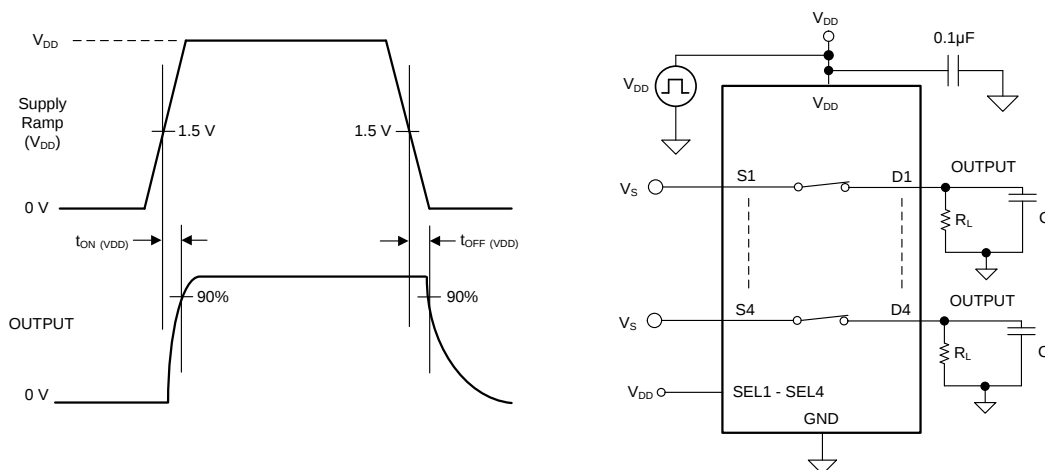


**Figure 31. Transition-Time Measurement Setup**

## 7.6 $T_{\text{ON}}(V_{\text{DD}})$ and $T_{\text{OFF}}(V_{\text{DD}})$ Time

$T_{\text{ON}}(V_{\text{DD}})$  time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is utilized to provide the timing of the device turning on in the system. The time constant from the load resistance and load capacitance can be added to the turn-on-VDD time to calculate system level timing. [Figure 32](#) shows the setup used to measure transition time, denoted by the symbol  $t_{\text{ON}}(V_{\text{DD}})$ .

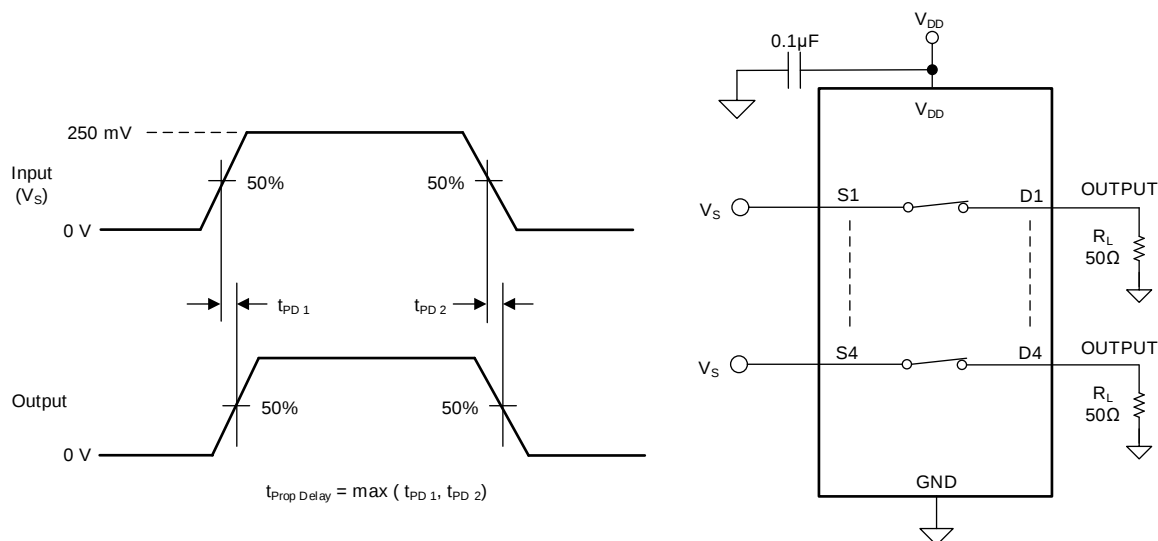
$T_{\text{OFF}}(V_{\text{DD}})$  time is defined as the time taken by the output of the device to fall to 90% after the enable has fallen past the supply threshold. The 90% measurement is utilized to provide the timing of the device turning off in the system. The time constant from the load resistance and load capacitance can be added to the turn-off-VDD time to calculate system level timing. [Figure 32](#) shows the setup used to measure transition time, denoted by the symbol  $t_{\text{OFF}}(V_{\text{DD}})$ .



**Figure 32. Turn-On-VDD and Turn-Off-VDD Time Measurement Setup**

## 7.7 Propagation Delay

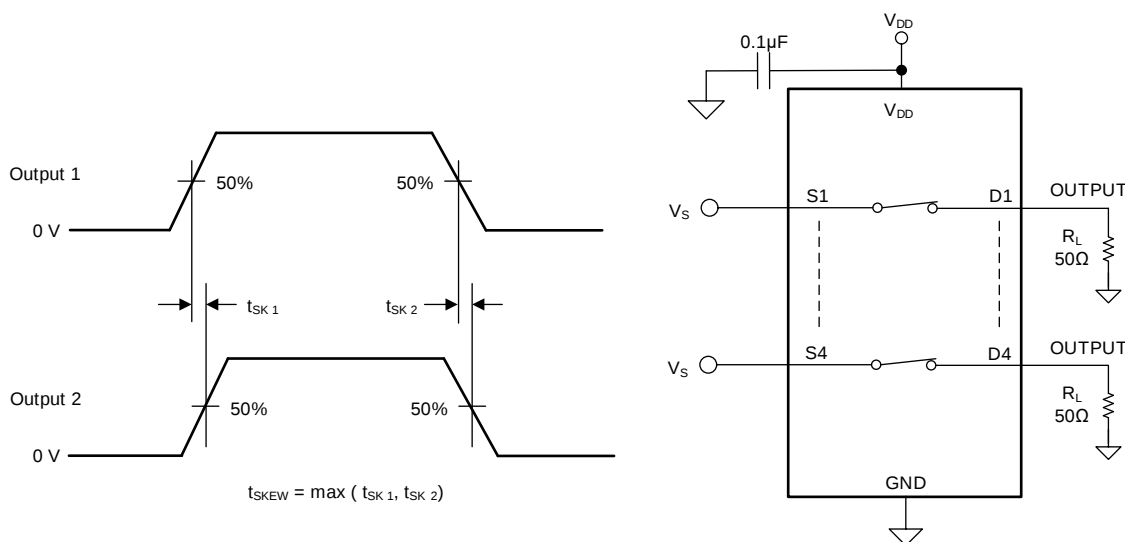
Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. [Figure 33](#) shows the setup used to measure propagation delay, denoted by the symbol  $t_{PD}$ .



**Figure 33. Propagation Delay Measurement Setup**

## 7.8 Skew

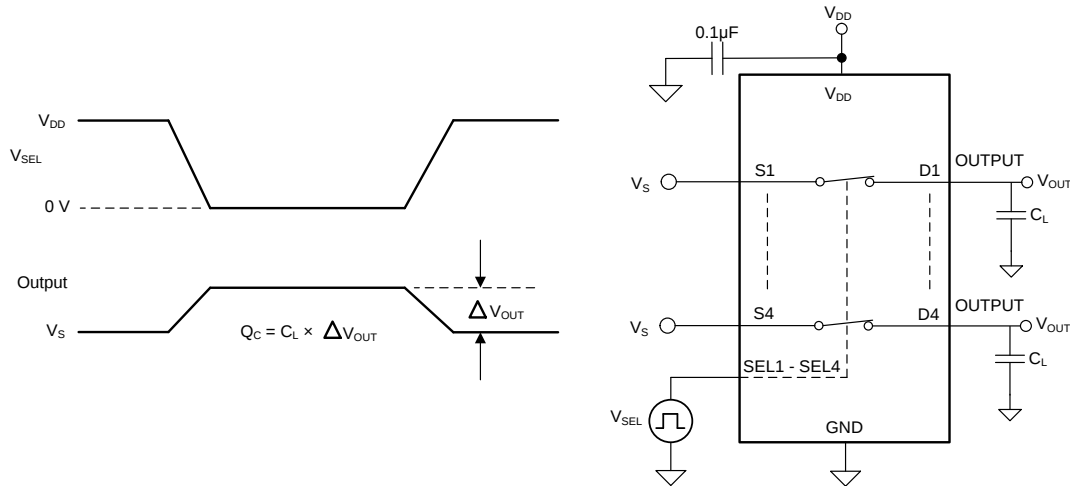
Skew is defined as the difference between propagation delays of any two outputs of the same device. The skew measurement is taken from the output of one channel rising or falling past 50% to a second channel rising or falling past the 50% threshold when the input signals are switched at the same time. [Figure 34](#) shows the setup used to measure skew, denoted by the symbol  $t_{SK}$ .



**Figure 34. Skew Measurement Setup**

## 7.9 Charge Injection

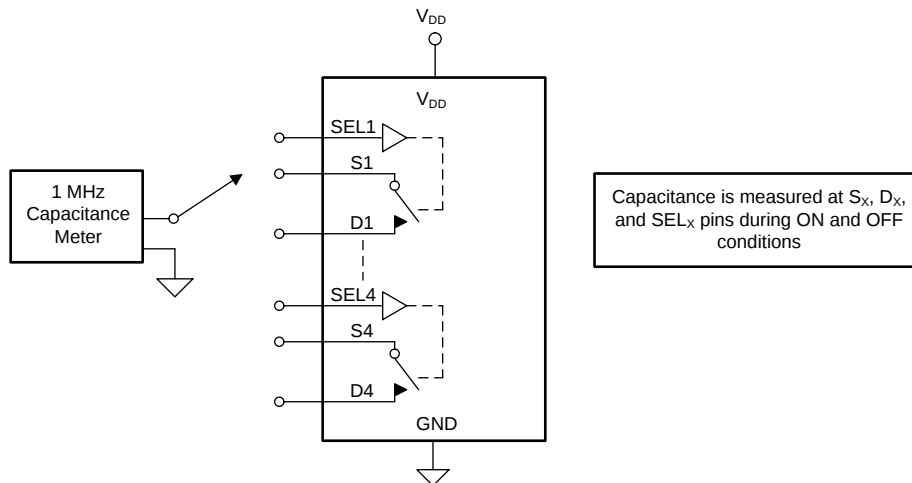
The amount of charge injected into the source or drain of the device during the falling or rising edge of the gate signal is known as charge injection, and is denoted by the symbol  $Q_C$ . [Figure 35](#) shows the setup used to measure charge injection from source ( $S_x$ ) to drain ( $D_x$ ).



**Figure 35. Charge-Injection Measurement Setup**

## 7.10 Capacitance

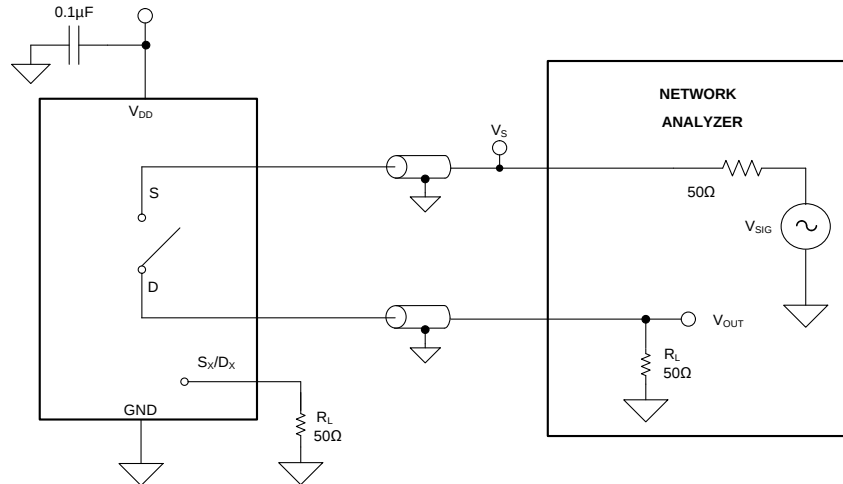
The parasitic capacitance of the device is captured at the source ( $S_x$ ), drain ( $D_x$ ), and select ( $SEL_x$ ) pins. The capacitance is measured in both the on and off state and is denoted by the symbol  $C_{ON}$  and  $C_{OFF}$ . [Figure 36](#) shows the setup used to measure capacitance.



**Figure 36. Capacitance Measurement Setup**

## 7.11 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (D<sub>x</sub>) of the device when a signal is applied to the source pin (S<sub>x</sub>) of an off-channel. The characteristic impedance, Z<sub>0</sub>, for the measurement is 50 Ω. [Figure 37](#) shows the setup used to measure off isolation. Use off isolation equation to compute off isolation.

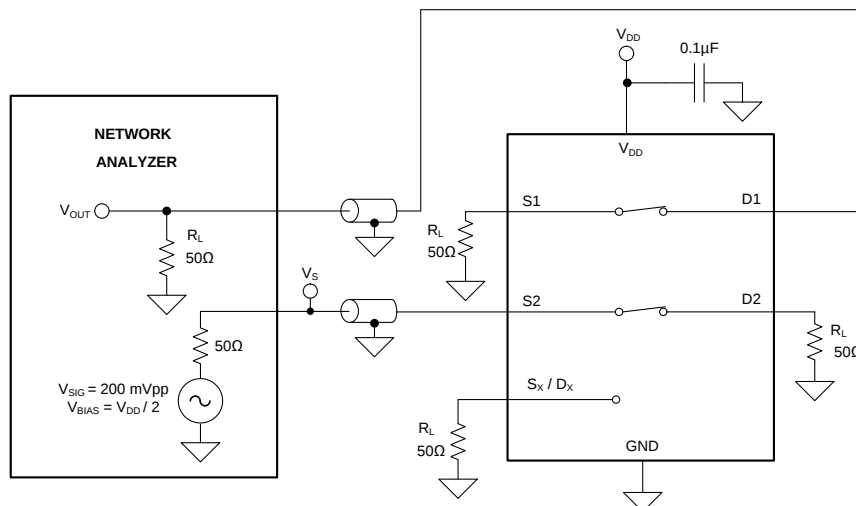


**Figure 37. Off Isolation Measurement Setup**

$$\text{Off Isolation} = 20 \cdot \text{Log} \left( \frac{V_{\text{OUT}}}{V_{\text{S}}} \right) \quad (1)$$

## 7.12 Channel-to-Channel Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (D<sub>x</sub>) of a different channel, when a signal is applied at the source pin (S<sub>x</sub>) of an on-channel. The characteristic impedance, Z<sub>0</sub>, for the measurement is 50 Ω. [Figure 38](#) shows the setup used to measure, and the equation used to compute crosstalk.

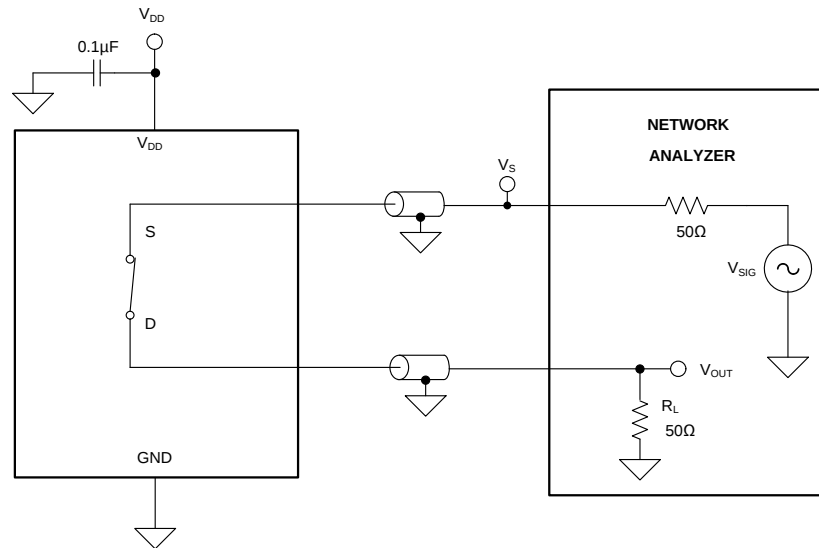


**Figure 38. Channel-to-Channel Crosstalk Measurement Setup**

$$\text{Channel-to-Channel Crosstalk} = 20 \cdot \text{Log} \left( \frac{V_{\text{OUT}}}{V_{\text{S}}} \right) \quad (2)$$

### 7.13 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (Dx) of the device. The characteristic impedance,  $Z_0$ , for the measurement is  $50\ \Omega$ . [Figure 39](#) shows the setup used to measure bandwidth.



**Figure 39. Bandwidth Measurement Setup**

## 8 Detailed Description

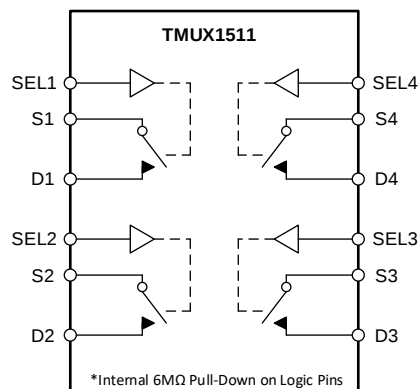
### 8.1 Overview

The TMUX1511 is a high speed 1:1 (SPST) 4-channel switch with powered-off protection up to 3.6 V. Wide operating supply of 1.5 V to 5.5 V allows for use in a broad array of applications from servers and communication equipment to industrial applications. The device supports bidirectional analog and digital signals on the source (Sx) and drain (Dx) pins. The wide bandwidth of this switch allows little or no attenuation of the high-speed signals at the outputs to pass with minimum edge and phase distortion as well as propagation delay.

The select (SELx) pins are active-high logic pins that control the connection between the source (Sx) and drain (Dx) pins of the device. Each channel of the TMUX1511 can be controlled independently through the associated select pin, or all four select pins can be tied together for simultaneous control of all channels with a single GPIO. Fail-Safe Logic circuitry allows voltages on the logic control pins to be applied before the supply pin, protecting the device from potential damage. All logic control inputs have 1.8V logic compatible thresholds, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range.

Powered-off protection up to 3.6 V on the signal path of the TMUX1511 provides isolation when the supply voltage is removed ( $V_{DD} = 0$  V). Without this protection feature, the system can back-power the supply rail through an internal ESD diode and cause potential damage to the system.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

#### 8.3.1 Bidirectional Operation

The TMUX1511 conducts equally well from source (Sx) to drain (Dx) or from drain (Dx) to source (Sx). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

#### 8.3.2 Beyond Supply Operation

When the TMUX1511 is powered from 1.5 V to 5.5 V, the valid signal path input/output voltage ranges from GND to  $V_{DD} \times 2$ , with a maximum input/output voltage of 5.5 V.

Example 1: If the TMUX1511 is powered at 1.5V, the signal range is 0 V to 3 V.

Example 2: If the TMUX1511 is powered at 3V, the signal range is 0 V to 5.5 V.

Example 3: If the TMUX1511 is powered at 5.5V, the signal range is 0 V to 5.5 V.

Other voltage levels not mentioned in the examples will support Beyond Supply Operation as long as the supply voltage falls within the recommended operation conditions of 1.5 V to 5.5 V.

## Feature Description (continued)

### 8.3.3 1.8 V Logic Compatible Inputs

The TMUX1511 has 1.8-V logic compatible control inputs. Regardless of the  $V_{DD}$  voltage, the control input thresholds remain fixed, allowing a 1.8-V processor GPIO to control the TMUX1511 without the need for an external translator. This saves both space and BOM cost. For more information on 1.8 V logic implementations refer to [Simplifying Design with 1.8 V logic Muxes and Switches](#).

### 8.3.4 Powered-off Protection

Powered-off protection up to 3.6 V on the signal path of the TMUX1511 provides isolation when the supply voltage is removed ( $V_{DD} = 0$  V). When the TMUX1511 is powered-off, the I/Os of the device remain in a high-Z state. Powered-off protection minimizes system complexity by removing the need for power supply sequencing on the signal path. The device performance remains within the leakage performance mentioned in the Electrical Specifications. For more information on powered-off protection refer to [Eliminate Power Sequencing with Powered-off Protection Signal Switches](#).

### 8.3.5 Fail-Safe Logic

The TMUX1511 has Fail-Safe Logic on the control input pins (SELx) which allows for operation up to 5.5 V, regardless of the state of the supply pin. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the select pins of the TMUX1511 to be ramped to 5.5 V while  $V_{DD} = 0$  V. Additionally, the feature enables operation of the TMUX1511 with  $V_{DD} = 1.5$  V while allowing the select pins to interface with a logic level of another device up to 5.5 V.

### 8.3.6 Low Capacitance

The TMUX1511 has very low capacitance in both the ON and OFF states on the source and drain pins. The low capacitance specification allows the TMUX1511 to be used in applications such as sample & hold circuits, and in the feedback path of an operation amplifier. Low capacitance helps to reduce large overshoots and ringing of an amplifier circuit when the switch is connected to the feedback network. Additionally, low capacitance improves system settling time by reducing the switch time constant formed by the On-resistance and On-capacitance. For more information on the benefits of low capacitance refer to [Improve Stability Issues with Low  \$C\_{ON}\$  Multiplexers](#).

### 8.3.7 Integrated Pull-Down Resistors

The TMUX1511 has internal weak pull-down resistors (6 M $\Omega$ ) to GND to ensure the logic pins are not left floating. This feature integrates up to four external components and reduces system size and cost.

## 8.4 Device Functional Modes

The select (SELx) pins are active-high logic pins that control the connection between the source (Sx) and drain (Dx) pins of the device. The TMUX1511 has internal weak pull-down resistors (6 M $\Omega$ ) to GND so that it powers-on with the switches disabled. When a given select pin of the TMUX1511 is pulled high, the corresponding switch conducts from the source to drain. When any of the select pins are pulled low, the corresponding switch is in an open state (HI-Z). Each channel of the TMUX1511 can be controlled independently through the associated select pin, or all four select pins can be tied together for simultaneous control of all channels with a single GPIO.

## 8.5 Truth Tables

表 1 shows the truth table for the TMUX1511.

表 1. TMUX1511 Truth Table

| SELx | Sx / Dx: STATE  |
|------|-----------------|
| 0    | Hi-Z (OFF)      |
| 1    | Conducting (ON) |

## 9 Application and Implementation

### 注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TMUX15xx family offers high-speed system performance across a wide operating supply (1.5 V to 5.5 V) and operating temperature (-40°C to +125°C). The TMUX1511 supports a number of features that improve system performance such as [1.8 V logic compatibility](#), [input voltages beyond supply](#), [Fail-Safe Logic](#), and [Powered-off Protection up to 3.6 V](#). These features make the TMUX15xx a family of protection multiplexers and switches that can reduce system complexity, board size, and overall system cost.

### 9.2 Typical Application

#### 9.2.1 Protocol / Signal Isolation

One useful application to take advantage of the TMUX1511 features is isolating various protocols from a processor or MCU such as JTAG, SPI, or standard GPIO signals. The device provides excellent isolation performance when the device is powered. The added benefit of powered-off protection allows a system to minimize complexity by eliminating the need for power sequencing in hot-swap and live insertion applications.

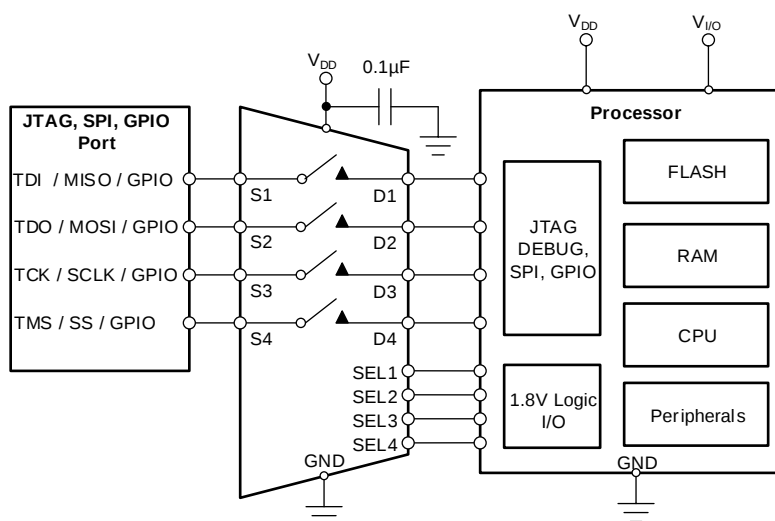


图 40. Isolation of JTAG, SPI, and GPIO Signals

#### 9.2.1.1 Design Requirements

For this design example, use the parameters listed in Table 2.

表 2. Design Parameters

| PARAMETERS                  | VALUES           |
|-----------------------------|------------------|
| Supply ( $V_{DD}$ )         | 3.3 V            |
| Input / Output signal range | 0 V to 3.3 V     |
| Control logic thresholds    | 1.8 V compatible |

### 9.2.1.2 Detailed Design Procedure

The TMUX1511 can be operated without any external components except for the supply decoupling capacitors. The device has internal weak pull-down resistors (6 M $\Omega$ ) to GND so that it powers-on with the switches disabled. All inputs signals passing through the switch must fall within the recommend operating conditions of the TMUX1511 including signal range and continuous current. For this design example, with a supply of 3.3 V, the signals can range from 0 V to 3.3 V when the device is powered. This example can also utilize the [Powered-off Protection](#) feature and the inputs can range from 0 V to 3.3 V when  $V_{DD} = 0$  V. The max continuous current can be 25 mA. Due to the voltage range and high speed capability, the TMUX1511example is suitable for use in JTAG and SPI applications beyond the 100 MHz maximum in a typical application.

### 9.2.1.3 Application Curves

Two important specifications when using a switch or multiplexer to pass signals are the device propagation delay and skew.

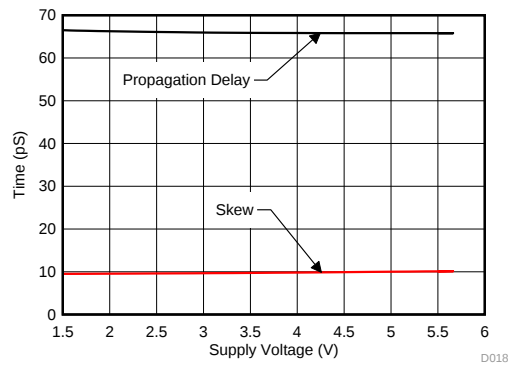


FIG 41. Propagation Delay and Skew Measurement

### 9.2.2 Transimpedance Amplifier Feedback Control

Switches and multiplexers are commonly used in the feedback path of amplifier circuits to provide configurable gain control. By using various resistor values on each switch path the TMUX1511 allows the system to have multiple gain settings. An external resistor, or utilizing 1 channel always being closed, ensures the amplifier isn't operating in an open loop configuration. A transimpedance amplifier (TIA) for photodiodes is a common circuit that requires gain control using a multi-channel switch to convert the output current of the photodiode into a voltage for the MCU or processor. The leakage current, capacitance, and charge injection performance of the TMUX1511 are key specifications to evaluate when selecting a device for gain control.

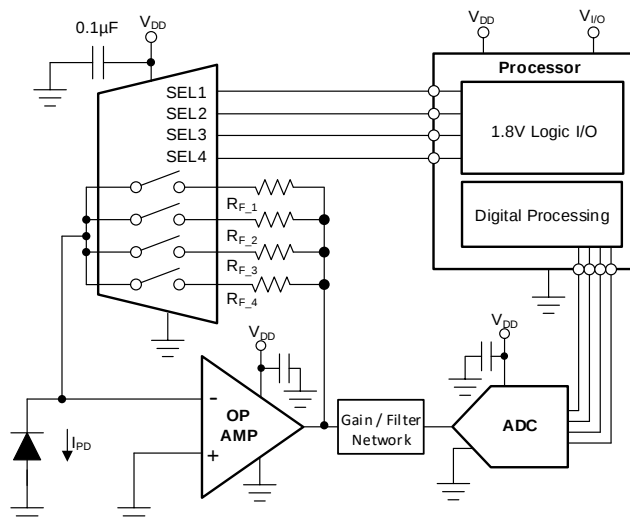


FIG 42. Multiplexing Gain for a TIA Circuit

### 9.2.2.1 Design Requirements

For this design example, use the parameters listed in Table 3.

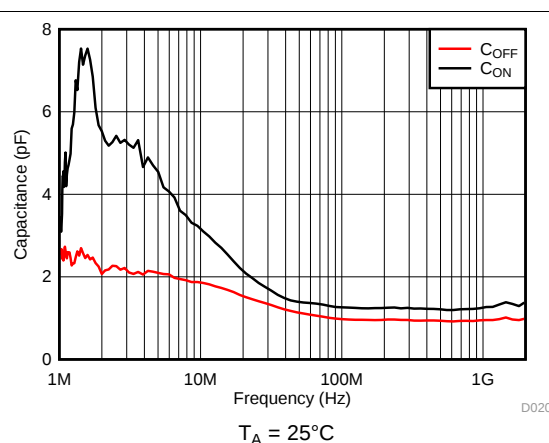
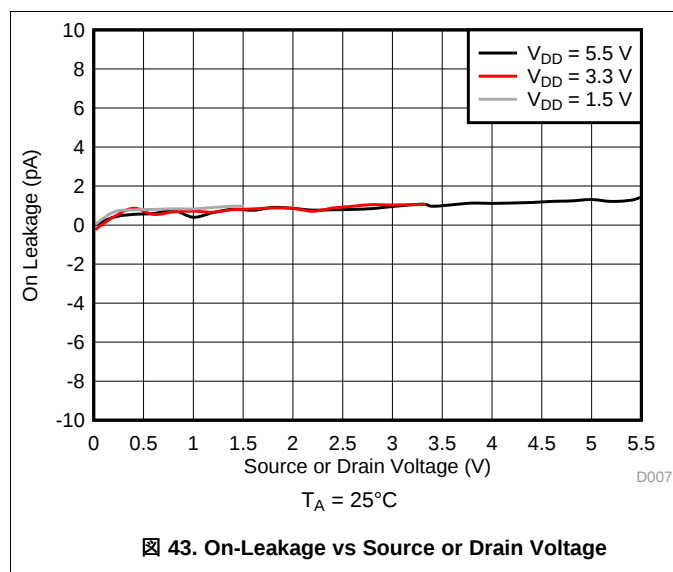
**表 3. Design Parameters**

| PARAMETERS                  | VALUES                  |
|-----------------------------|-------------------------|
| Supply ( $V_{DD}$ )         | 5 V                     |
| Input / Output signal range | 0 $\mu$ A to 10 $\mu$ A |
| Control logic thresholds    | 1.8 V compatible        |

### 9.2.2.2 Detailed Design Procedure

Photodiodes commonly have a current output that ranges from a few hundred picoamps to tens of microamps based on the amount of light being absorbed. The TMUX1511 has a typical On-leakage current of less than 10 pA which would lead to an accuracy well within 1% of a full scale 10  $\mu$ A signal. The low ON and OFF capacitance of the TMUX1511 improves system stability by minimizing the total capacitance on the output of the amplifier. Lower capacitance leads to less overshoot and ringing in the system which can cause the amplifier circuit to go unstable if the phase margin is not at least 45°. Refer to [Improve Stability Issues with Low  \$C\_{ON}\$  Multiplexers](#) for more information on calculating the phase margin vs. percent overshoot.

### 9.2.2.3 Application Curves



## 10 Power Supply Recommendations

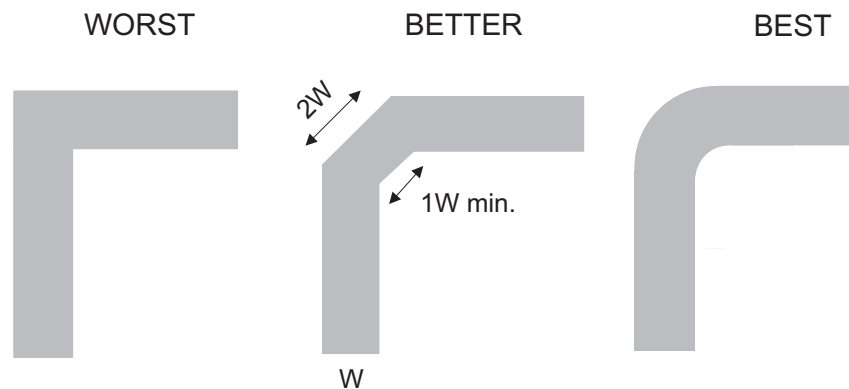
The TMUX1511 operates across a wide supply range of 1.5 V to 5.5 V. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the  $V_{DD}$  supply to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1  $\mu$ F to 10  $\mu$ F from  $V_{DD}$  to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes.

## 11 Layout

### 11.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners. [Figure 45](#) shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



**Figure 45. Trace Example**

Route the high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

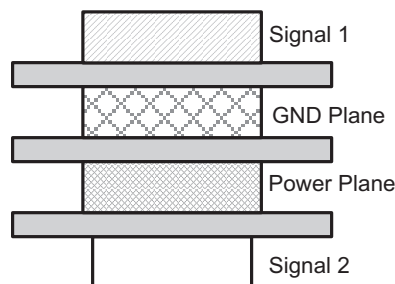
Do not route high speed signal traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or ICs that use or duplicate clock signals.

Avoid stubs on the high-speed signals traces because they cause signal reflections.

Route all high-speed signal traces over continuous GND planes, with no interruptions.

Avoid crossing over anti-etch, commonly found with plane splits.

When working with high frequencies, a printed circuit board with at least four layers is recommended; two signal layers separated by a ground and power layer as shown in [Figure 46](#).



**Figure 46. Example Layout**

The majority of signal traces must run on a single layer, preferably Signal 1. Immediately next to this layer must be the GND plane, which is solid with no cuts. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies.

[Figure 47](#) illustrates an example of a PCB layout with the TMUX1511. Some key considerations are:

## Layout Guidelines (continued)

Decouple the  $V_{DD}$  pin with a 0.1- $\mu$ F capacitor, placed as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the  $V_{DD}$  supply.

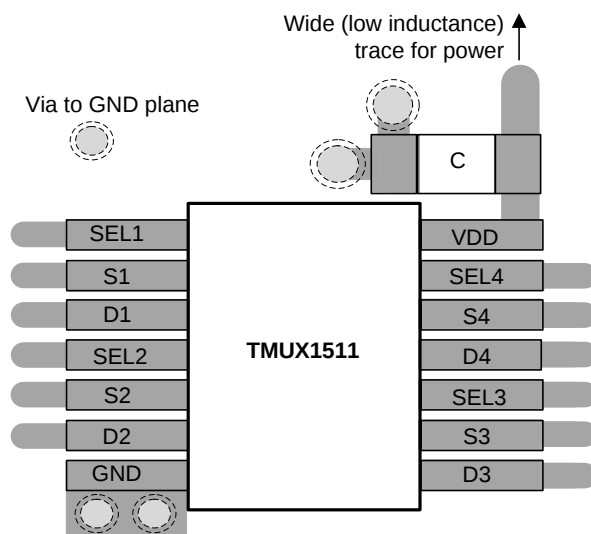
High-speed switches require proper layout and design procedures for optimum performance.

Keep the input lines as short as possible.

Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.

Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.

## 11.2 Layout Example



✎ 47. Example Layout

## 12 デバイスおよびドキュメントのサポート

### 12.1 ドキュメントのサポート

#### 12.1.1 関連資料

テキサス・インスツルメンツ、『[低CONマルチプレクサにおける安定性の問題の改善](#)』

テキサス・インスツルメンツ、『[1.8Vロジックのマルチプレクサおよびスイッチにおける設計の単純化](#)』

テキサス・インスツルメンツ、『[電源オフ保護を備えた信号スイッチで電源シーケンシングを不要に](#)』

テキサス・インスツルメンツ、『[高速インターフェイスのレイアウト・ガイドライン](#)』

テキサス・インスツルメンツ、『[高速レイアウト・ガイドライン](#)』

テキサス・インスツルメンツ、『[QFN/SONのPCB実装](#)』

テキサス・インスツルメンツ、『[クワッド・フラットパック・リード端子なしロジック・パッケージ](#)』

### 12.2 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、[ti.com](http://ti.com)のデバイス製品フォルダを開いてください。右上の隅にある「通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

### 12.3 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

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**設計サポート** *TIの設計サポート* 役に立つE2Eフォーラムや、設計サポート・ツールをすばやく見つけることができます。技術サポート用の連絡先情報も参照できます。

### 12.4 商標

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### 12.5 静電気放電に関する注意事項



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### 12.6 Glossary

**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

## PACKAGING INFORMATION

| Orderable Device | Status<br>(1) | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|--------------------|------|----------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| TMUX1511PWR      | ACTIVE        | TSSOP        | PW                 | 14   | 2000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | MUX1511                 | <a href="#">Samples</a> |
| TMUX1511RSVR     | ACTIVE        | UQFN         | RSV                | 16   | 3000           | RoHS & Green    | NIPDAU                               | Level-1-260C-UNLIM   | -40 to 125   | 1511                    | <a href="#">Samples</a> |

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TMUX1511PWR  | TSSOP        | PW              | 14   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| TMUX1511RSVR | UQFN         | RSV             | 16   | 3000 | 178.0              | 13.5               | 2.1     | 2.9     | 0.75    | 4.0     | 12.0   | Q1            |

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

| Device       | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TMUX1511PWR  | TSSOP        | PW              | 14   | 2000 | 356.0       | 356.0      | 35.0        |
| TMUX1511RSVR | UQFN         | RSV             | 16   | 3000 | 189.0       | 185.0      | 36.0        |

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



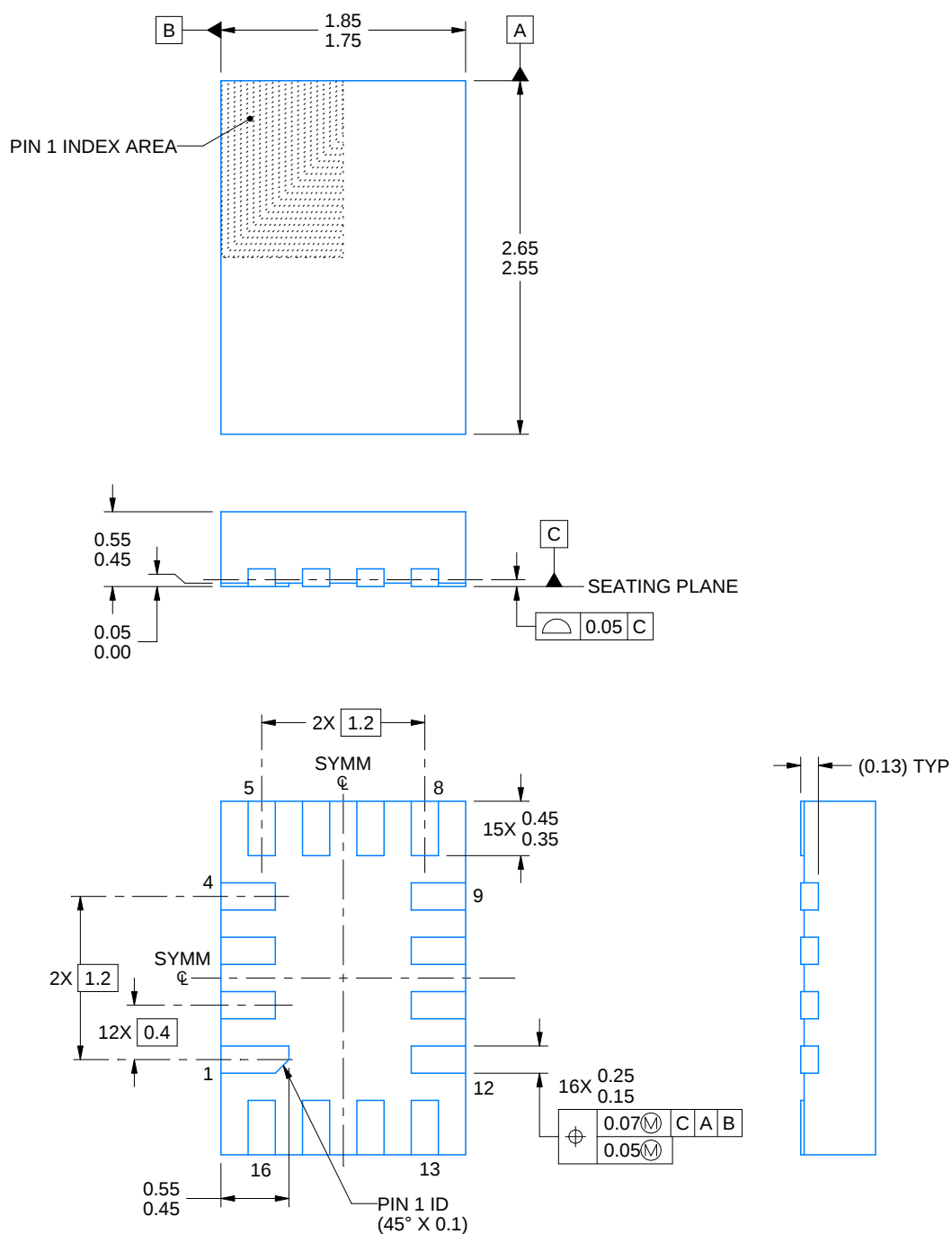
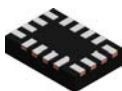
- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
  - E. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
  - This drawing is subject to change without notice.
  - Publication IPC-7351 is recommended for alternate designs.
  - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



4220314/C 02/2020

## NOTES:

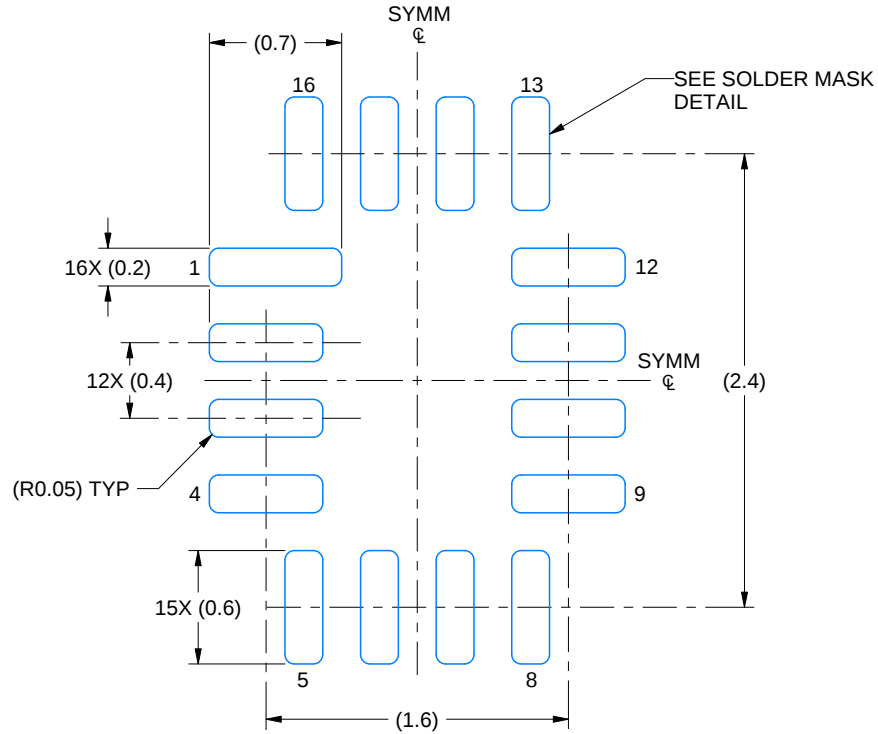
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

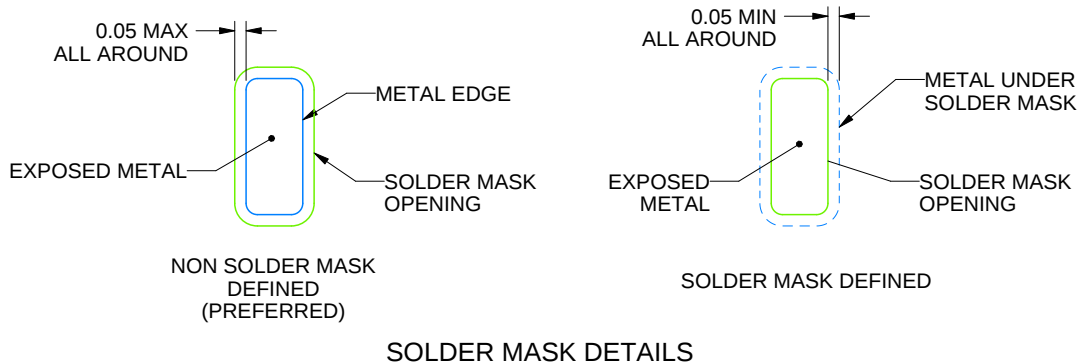
RSV0016A

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 25X



4220314/C 02/2020

NOTES: (continued)

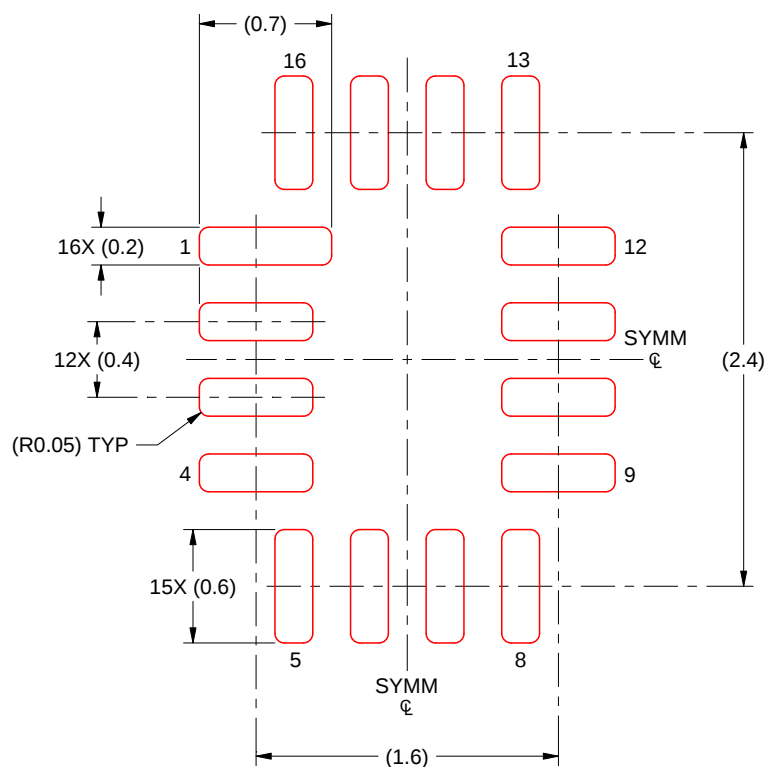
3. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

## EXAMPLE STENCIL DESIGN

RSV0016A

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE: 25X

4220314/C 02/2020

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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